Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/643,538	CHO ET AL.	
Examiner	Art Unit	
DUNG A. LE	2818	

SEARCHED			
Class	Subclass	Date	Examiner
438	257-259	10/27/2004	DLE
	265-266		/
	593-596	V	V

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
438	257-259	10/27/2004	DLE	
	265-266	V	$\bigvee$	
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SEARCH NOT (INCLUDING SEARCH	ES STRATEGY	
	DATE	EXMR
EAST, JPO, EPO, IEEE, PGPUB,IBM	10/27/2004	DLE